Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/701,824	CHANG ET AL.	
	Examiner	Art Unit	
	Hsien-ming Lee	2823	

Hsien-ming Lee

	SEARCHED				
Class	Subclass	Date	Examiner		
438	14, 16	3/17/05	Lu		
257	48, 414	1	1		
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INTERFERENCE SEARCHED					
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SEARCH NOT (INCLUDING SEARCH)
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